

Search Notes

Application/Control No.

10/651,133

Examiner

Benjamin C. Lee

Applicant(s)/Patent under
Reexamination

CRANFILL ET AL.

Art Unit

2612

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
340	407.1	8/21/2006	<i>ML</i>
	7.6	↓	↓
455	567	↓	↓
434	114	↓	↓

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (Text search history printout)	8/23/2006	<i>ML</i>
	8/21/2006	<i>ML</i>